

General Description

The CMP3205 is a N-channel Power MOSFET. It has specifically been designed to minimize input capacitance and gate charge. The device is therefore suitable in advanced high-efficiency switching applications.

Features

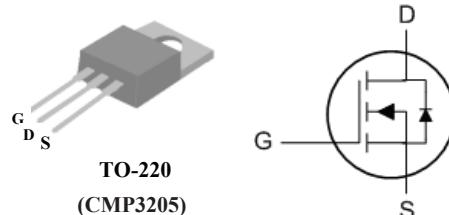
- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Absolute Maximum Ratings**Product Summary**

BVDSS	RDSON	ID
60V	8.0mΩ	100A

Applications

- LED POWER CONTROLLER
- DC-DC & DC-AC CONVERTERS
- HIGH CURRENT, HIGH SPEED SWITCHING
- SOLENOID AND RELAY DRIVERS
- MOTOR CONTROL, AUDIO AMPLIFIERS

TO220 Pin Configuration

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	60	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current ¹	100	A
I _D @T _C =100°C	Continuous Drain Current ¹	68	A
I _{DM}	Pulsed Drain Current ²	300	A
EAS	Single Pulse Avalanche Energy ³	600	mJ
I _{AS}	Avalanche Current	62	A
P _D @T _C =25°C	Total Power Dissipation	190	W
T _{STG}	Storage Temperature Range	-55 to 175	°C
T _J	Operating Junction Temperature Range	-55 to 175	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-ambient ¹	---	62.5	°C/W
R _{θJC}	Thermal Resistance Junction-case	---	0.79	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	60	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BVDSS Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	---	0.057	---	$\text{V}/^\circ\text{C}$
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ²	$V_{\text{GS}}=10\text{V}$, $I_D=62\text{A}$	---	7.8	8.0	$\text{m}\Omega$
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	2	3	4	V
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=\text{Max rating}$, $V_{\text{GS}}=0\text{V}$	---	---	1	μA
		$V_{\text{DS}}=\text{Max rating}$, $V_{\text{GS}}=0\text{V}$ @ 125°C	---	---	10	
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
g_{fs}	Forward Transconductance	$V_{\text{DS}}=25\text{V}$, $I_D=62\text{A}$	---	42	---	S
R_g	Gate Resistance	$V_{\text{DS}}=0\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	3.3	---	Ω
Q_g	Total Gate Charge	$I_D=62\text{A}$	---	71	---	nC
Q_{gs}	Gate-Source Charge	$V_{\text{DS}}=48\text{V}$	---	16	---	
Q_{gd}	Gate-Drain Charge	$V_{\text{GS}}=10\text{V}$	---	28	---	
$T_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DS}}=30\text{V}$ $I_D=62\text{A}$ $R_g=4.7\Omega$, $V_{\text{GS}}=10\text{V}$	---	16	---	ns
T_r	Rise Time		---	57	---	
$T_{\text{d(off)}}$	Turn-Off Delay Time		---	85	---	
T_f	Fall Time		---	71	---	
C_{iss}	Input Capacitance	$V_{\text{DS}}=25\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	2422	---	pF
C_{oss}	Output Capacitance		---	522	---	
C_{rss}	Reverse Transfer Capacitance		---	166	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current ¹	$V_G=V_D=0\text{V}$, Force Current	---	---	100	A
I_{SM}	Pulsed Source Current ²		---	---	300	A
V_{SD}	Diode Forward Voltage ²	$V_{\text{GS}}=0\text{V}$, $I_s=62\text{A}$, $T_J=25^\circ\text{C}$	---	---	1.5	V

Note :

1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.2.The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$ 3.The EAS data shows Max. rating . The test condition is $V_{\text{DD}}=25\text{V}$, $V_{\text{GS}}=10\text{V}$, $L=0.1\text{mH}$, $I_{\text{AS}}=62\text{A}$